- 15-V Digital or ±7.5-V Peak-to-Peak **Switching**
- 125-Ω Typical On-State Resistance for 15-V Operation
- Switch On-State Resistance Matched to Within 5  $\Omega$  Over 15-V Signal-Input Range
- **On-State Resistance Flat Over Full** Peak-to-Peak Signal Range
- High On/Off Output-Voltage Ratio: 80 dB Typical at  $f_{is} = 10 \text{ kHz}$ ,  $R_L = 1 \text{ k}\Omega$
- High Degree of Linearity: <0.5% Distortion Typical at  $f_{is} = 1 \text{ kHz}$ ,  $V_{is} = 5 \text{ V p-p}$ ,  $V_{DD} - V_{SS} \ge 10 \text{ V}, R_L = 10 \text{ k}\Omega$
- Extremely Low Off-State Switch Leakage, Resulting in Very Low Offset Current and High Effective Off-State Resistance: 10 pA Typical at  $V_{DD} - V_{SS} = 10 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$
- **Extremely High Control Input Impedance** (Control Circuit Isolated From Signal Circuit):  $10^{12} \Omega$  Typical
- Low Crosstalk Between Switches: -50 dB Typical at  $f_{is} = 8$  MHz,  $R_L = 1$  k $\Omega$

- **Matched Control-Input to Signal-Output** Capacitance: Reduces Output Signal
- Frequency Response, Switch On = 40 MHz **Typical**
- 100% Tested for Quiescent Current at 20 V
- 5-V, 10-V, and 15-V Parametric Ratings
- **Meets All Requirements of JEDEC Tentative** Standard No. 13-B, Standard Specifications for Description of "B" Series CMOS Devices
- **Applications:** 
  - Analog Signal Switching/Multiplexing: Signal Gating, Modulator, Squelch Control, Demodulator, Chopper, Commutating Switch
  - Digital Signal Switching/Multiplexing
  - Transmission-Gate Logic Implementation
  - Analog-to-Digital and Digital-to-Analog Conversion
  - Digital Control of Frequency, Impedance, Phase, and Analog-Signal Gain

#### E, F, M, NS, OR PW PACKAGE (TOP VIEW) 14 🛮 V<sub>DD</sub> SIG A IN/OUT [ SIG A OUT/IN 12 13 CONTROL A SIG B OUT/IN 3 12 CONTROL D SIG B IN/OUT I 4 11 SIG D IN/OUT CONTROL B 1 5 10 SIG D OUT/IN CONTROL C 6 9 SIG C OUT/IN 8 SIG C IN/OUT V<sub>SS</sub> [

#### description/ordering information

The CD4066B is a quad bilateral switch intended for the transmission or multiplexing of analog or digital signals. It is pin-for-pin compatible with the CD4016B, but exhibits a much lower on-state resistance. In addition, the on-state resistance is relatively constant over the full signal-input range.

The CD4066B consists of four bilateral switches, each with independent controls. Both the p and the n devices in a given switch are biased on or off simultaneously by the control signal. As shown in Figure 1, the well of the n-channel device on each switch is tied to either the input (when the switch is on) or to V<sub>SS</sub> (when the switch is off). This configuration eliminates the variation of the switch-transistor threshold voltage with input signal and, thus, keeps the on-state resistance low over the full operating-signal range.

The advantages over single-channel switches include peak input-signal voltage swings equal to the full supply voltage and more constant on-state impedance over the input-signal range. However, for sample-and-hold applications, the CD4016B is recommended.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

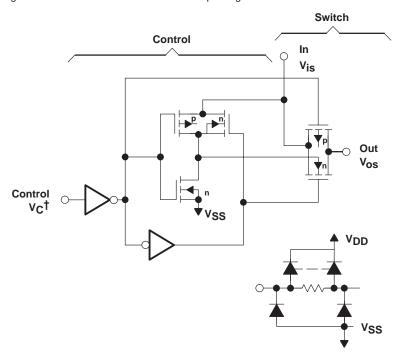


#### description/ordering information (continued)

#### **ORDERING INFORMATION**

| TA             | PACK       | AGE†         | ORDERABLE<br>PART NUMBER | TOP-SIDE<br>MARKING |  |
|----------------|------------|--------------|--------------------------|---------------------|--|
|                | CDIP – F   | Tube of 25   | CD4066BF3A               | CD4066BF3A          |  |
|                | PDIP – E   | Tube of 25   | CD4066BE                 | CD4066BE            |  |
|                |            | Tube of 50   | CD4066BM                 |                     |  |
| -55°C to 125°C | SOIC - M   | Reel of 2500 | CD4066BM96               | CD4066BM            |  |
| -55 C to 125 C |            | Reel of 250  | CD4066BMT                |                     |  |
|                | SOP - NS   | Reel of 2000 | CD4066BNSR               | CD4066B             |  |
|                | TSSOP – PW | Tube of 90   | CD4066BPW                | CM066B              |  |
|                | 1330F = FW | Reel of 2000 | CD4066BPWR               | CIVIOOOB            |  |

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



<sup>&</sup>lt;sup>†</sup> All control inputs are protected by the CMOS protection network.

NOTES: A. All p substrates are connected to  $V_{\mbox{\scriptsize DD}}$ .

- B. Normal operation control-line biasing: switch on (logic 1),  $V_C = V_{DD}$ ; switch off (logic 0),  $V_C = V_{SS}$
- C. Signal-level range:  $V_{SS} \le V_{is} \le V_{DD}$

92CS-29113

Figure 1. Schematic Diagram of One-of-Four Identical Switches and Associated Control Circuitry



SCHS051D - NOVEMBER 1998 - REVISED SEPTEMBER 2003

# absolute maximum ratings over operating free-air temperature (unless otherwise noted) † DC supply-voltage range, $V_{DD}$ (voltages referenced to $V_{SS}$ terminal) ... -0.5 V to 20 V Input voltage range, $V_{is}$ (all inputs) ... -0.5 V to $V_{DD}$ + 0.5 V DC input current, $I_{IN}$ (any one input) ... ±10 mA Package thermal impedance, $\theta_{JA}$ (see Note 1): E package ... 80°C/W M package ... 86°C/W NS package ... 76°C/W PW package ... 113°C/W Lead temperature (during soldering): At distance 1/16 $\pm$ 1/32 inch (1,59 $\pm$ 0,79 mm) from case for 10 s max ... 265°C Storage temperature range, $T_{stg}$ ... -65°C to 150°C

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

#### recommended operating conditions

|          |                                | MIN | MAX | UNIT |
|----------|--------------------------------|-----|-----|------|
| $V_{DD}$ | Supply voltage                 | 3   | 18  | V    |
| TA       | Operating free-air temperature | -55 | 125 | °C   |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### electrical characteristics

|                  |   |   |                                |                 | LIN   | IITS AT II | NDICATE | D TEMPE | RATURE            | S    |      |  |
|------------------|---|---|--------------------------------|-----------------|-------|------------|---------|---------|-------------------|------|------|--|
|                  | PARAMETER                                       | TEST CONDITIONS   | VIN                            | V <sub>DD</sub> | FF00  | 4000       | 0500    | 40500   | 25                | °C   | UNIT |  |
|                  |   |   | (V)                            | (V)             | –55°C | -40°C      | 85°C    | 125°C   | TYP               | MAX  |      |  |
|                  |   |   | 0, 5                           | 5               | 0.25  | 0.25       | 7.5     | 7.5     | 0.01              | 0.25 |      |  |
|                  | Quiescent device                                |   | 0, 10                          | 10              | 0.5   | 0.5        | 15      | 15      | 0.01              | 0.5  |      |  |
| IDD              | current   |   | 0, 15                          | 15              | 1     | 1          | 30      | 30      | 0.01              | 1    | μΑ   |  |
|                  |   |   | 0, 20                          | 20              | 5     | 5          | 150     | 150     | 0.02              | 5    |      |  |
| Signal           | Inputs (Vis) and Outpu                          |   |                                |                 |       |            |         | •       | ı                 |      |      |  |
|                  |   | $V_C = V_{DD}$ ,<br>$R_L = 10 \text{ k}\Omega \text{ returned}$   |                                | 5               | 800   | 850        | 1200    | 1300    | 470               | 1050 |      |  |
| ron              | On-state resistance (max)                       | to $\frac{\left(V_{DD}-V_{SS}\right)}{2}$ ,   |                                | 10              | 310   | 330        | 500     | 550     | 180               | 400  | Ω    |  |
|                  |   | $V_{is} = V_{SS}$ to $V_{DD}$   |                                | 15              | 200   | 210        | 300     | 320     | 125               | 240  |      |  |
|                  | On-state resistance                             |   |                                | 5               |       |            |         |         | 15                |      |      |  |
| $\Delta r_{on}$  | difference between                              | $R_L = 10 \text{ k}\Omega, V_C = V_{DD}$  | 10                             |                 |       |            |         | 10      |                   | Ω    |      |  |
|                  | any two switches                                |   |                                | 15              |       |            |         |         | 5                 |      |      |  |
| THD              | Total harmonic distortion                       | $V_C = V_{DD} = 5 \text{ V}, V_{SS} = -5$<br>$V_{is(p-p)} = 5 \text{ V} \text{ (sine wave ce}$<br>$R_L = 10 \text{ k}\Omega, f_{is} = 1\text{-kHz sine}$  | n 0 V),                        |                 |       |            |         | 0.4     |                   | %    |      |  |
|                  | -3-dB cutoff<br>frequency<br>(switch on)        | $V_C = V_{DD} = 5 \text{ V}, V_{SS} = -5 \text{ V}$<br>(sine wave centered on 0 V   | ) = 5 V<br>kΩ                  |                 |       |            |         | 40      |                   | MHz  |      |  |
|                  | -50-dB feedthrough frequency (switch off)       | $V_C = V_{SS} = -5 \text{ V}, V_{is(p-p)} = (\text{sine wave centered on } 0 \text{ V})$  | = 5 V<br>), R <sub>L</sub> = 1 | kΩ              |       |            |         |         | 1                 |      | MHz  |  |
| I <sub>iS</sub>  | Input/output leakage current (switch off) (max) | $V_C = 0 \text{ V}, V_{is} = 18 \text{ V}, V_{os} = $ and $V_C = 0 \text{ V}, V_{is} = 0 \text{ V}, V_{os} = 1 $  |                                | 18              | ±0.1  | ±0.1       | ±1      | ±1      | ±10 <sup>-5</sup> | ±0.1 | μА   |  |
|                  | –50-dB crosstalk frequency                      | $\begin{array}{l} V_{C}(A) = V_{DD} = 5 \text{ V,} \\ V_{C}(B) = V_{SS} = -5 \text{ V,} \\ V_{is}(A) = 5 \text{ V}_{p\text{-}p}, 50\text{-}\Omega \text{ sourc} \\ R_{L} = 1 \text{ k}\Omega \end{array}$ | ce,                            |                 |       |            |         |         | 8                 |      | MHz  |  |
|                  | Propagation delay                               | $R_L = 200 \text{ k}\Omega, V_C = V_{DD},$<br>$V_{SS} = GND, C_L = 50 \text{ pF},$  |                                | 5               |       |            |         |         | 20                | 40   | ns   |  |
| t <sub>pd</sub>  | (signal input to signal output)                 | V <sub>is</sub> = 10 V<br>(square wave centered on 5  | 5 V)                           | 10              |       |            |         |         | 10                | 20   |      |  |
|                  | Signal Output)                                  | $t_{\rm r}$ , $t_{\rm f} = 20 \text{ ns}$   | ,                              | 15              |       |            |         |         | 7                 | 15   |      |  |
| C <sub>is</sub>  | Input capacitance                               | $V_{DD} = 5 \text{ V}, V_{C} = V_{SS} = -5$   |                                |                 |       |            |         |         | 8                 |      | pF   |  |
| Cos              | Output capacitance                              | $V_{DD} = 5 \text{ V}, V_{C} = V_{SS} = -5$   |                                |                 |       |            |         |         | 8                 |      | pF   |  |
| C <sub>ios</sub> | Feedthrough                                     | $V_{DD} = 5 \text{ V}, V_{C} = V_{SS} = -5$   | V                              |                 |       |            |         |         | 0.5               |      | pF   |  |

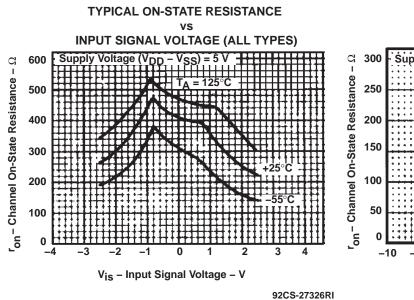


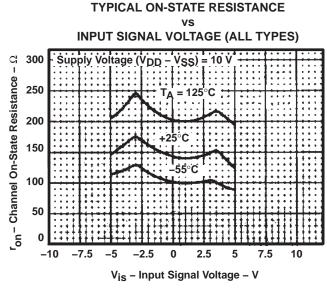
## electrical characteristics (continued)

|                 |  |   |                 | LIN   | IITS AT II | NDICATE | D TEMPE | RATURE | S    |      |  |
|-----------------|--|---|-----------------|-------|------------|---------|---------|--------|------|------|--|
|                 | CHARACTERISTIC                             | TEST CONDITIONS   | V <sub>DD</sub> |       |            |         | 40500   | 25     | °C   | UNIT |  |
|                 |  |   | (V)             | −55°C | -40°C      | 85°C    | 125°C   | TYP    | MAX  |      |  |
| Contro          | ol (VC)                                    |   |                 |       |            |         |         |        |      |      |  |
|                 | Occided Second                             | I <sub>is</sub>   < 10 μA,  | 5               | 1     | 1          | 1       | 1       |        | 1    |      |  |
| VILC            | Control input, low voltage (max)           | $V_{is} = V_{SS}$ , $V_{OS} = V_{DD}$ , and   | 10              | 2     | 2          | 2       | 2       |        | 2    | V    |  |
|                 |  | $V_{iS} = V_{DD}, V_{OS} = V_{SS}$  | 15              | 2     | 2          | 2       | 2       |        | 2    |      |  |
|                 | Ocated Count                               |   | 5               |       |            | 3.5 (1  | MIN)    |        |      |      |  |
| VIHC            | Control input,<br>high voltage             | See Figure 6  | 10              |       | V          |         |         |        |      |      |  |
|                 | riigii voitago                             |   | 15              |       | 11 (MIN)   |         |         |        |      |      |  |
| I <sub>IN</sub> | Input current (max)                        | $V_{is} \le V_{DD}$ , $V_{DD} - V_{SS} = 18 \text{ V}$ , $V_{CC} \le V_{DD} - V_{SS}$             | 18              | ±0.1  | ±0.1       | ±1      | ±1      | ±10-5  | ±0.1 | μΑ   |  |
|                 | Crosstalk (control input to signal output) | $V_C = 10 \text{ V (square wave)},$<br>$t_f$ , $t_f = 20 \text{ ns}$ , $R_L = 10 \text{ k}\Omega$ | 10              |       |            |         |         | 50     |      | mV   |  |
|                 |  |   | 5               |       |            |         |         | 35     | 70   |      |  |
|                 | Turn-on and turn-off propagation delay     | $V_{IN} = V_{DD}$ , $t_r$ , $t_f = 20$ ns,<br>$C_{I} = 50$ pF, $R_{I} = 1$ k $\Omega$             | 10              |       |            |         |         | 20     | 40   | ns   |  |
|                 | propagation delay                          | OL = 30 pr, KL = 1 Ks2  | 15              |       |            |         |         | 15     | 30   |      |  |
|                 |  | $V_{iS} = V_{DD}$ , $V_{SS} = GND$ , $R_L = 1 \text{ k}\Omega$ to GND, $C_L = 50 \text{ pF}$ ,    | 5               |       |            |         |         | 6      |      | MHz  |  |
|                 | Maximum control input repetition rate      | V <sub>C</sub> = 10 V (square wave  | 10              |       |            |         |         | 9      |      |      |  |
|                 | -  | centered on 5 V), $t_r$ , $t_f = 20$ ns,<br>$V_{OS} = 1/2 V_{OS}$ at 1 kHz                        | 15              |       |            |         |         | 9.5    |      |      |  |
| Cl              | Input capacitance                          |   |                 |       |            |         |         | 5      | 7.5  | pF   |  |

## switching characteristics

| V <sub>DD</sub><br>(V) |                     | SWITCH |                                |       |       |       |      |     |
|------------------------|---------------------|--------|--------------------------------|-------|-------|-------|------|-----|
|                        | V <sub>is</sub> (V) |        | OUTPUT, V <sub>OS</sub><br>(V) |       |       |       |      |     |
|                        |                     | –55°C  | -40°C                          | 25°C  | 85°C  | 125°C | MIN  | MAX |
| 5                      | 0                   | 0.64   | 0.61                           | 0.51  | 0.42  | 0.36  |      | 0.4 |
| 5                      | 5                   | -0.64  | -0.61                          | -0.51 | -0.42 | -0.36 | 4.6  |     |
| 10                     | 0                   | 1.6    | 1.5                            | 1.3   | 1.1   | 0.9   |      | 0.5 |
| 10                     | 10                  | -1.6   | -1.5                           | -1.3  | -1.1  | -0.9  | 9.5  |     |
| 15                     | 0                   | 4.2    | 4                              | 3.4   | 2.8   | 2.4   |      | 1.5 |
| 15                     | 15                  | -4.2   | -4                             | -3.4  | -2.8  | -2.4  | 13.5 |     |





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Figure 2

**TYPICAL ON-STATE RESISTANCE INPUT SIGNAL VOLTAGE (ALL TYPES)** 

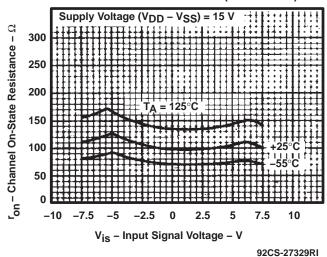


Figure 4

**TYPICAL ON-STATE RESISTANCE** 

Figure 3

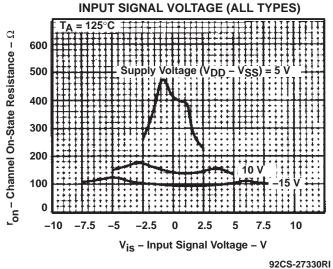
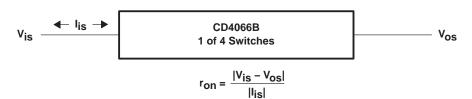


Figure 5





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Figure 6. Determination of ron as a Test Condition for Control-Input High-Voltage (VIHC) Specification

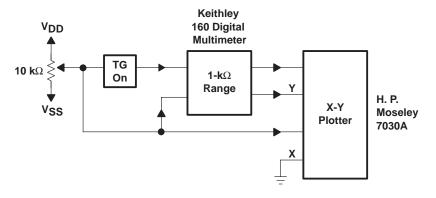
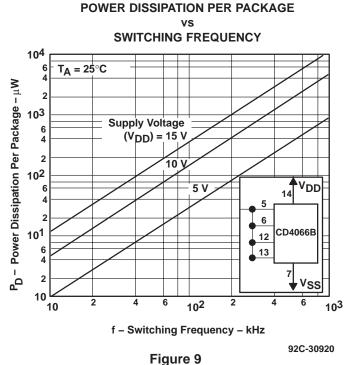
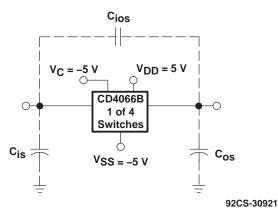


Figure 7. Channel On-State Resistance Measurement Circuit

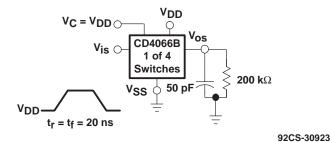
## **TYPICAL ON CHARACTERISTICS FOR 1 OF 4 CHANNELS** AMBIENT TEMPERATURE (TA) = 25°C VD0 = 2.5 V, VSS = -2.5 V ik 🛮 2 500₽ V<sub>O</sub> - Output Voltage - V 1000 $V_C = V_{DD}$ CD4066B 1 of 4 Switches ٧ss All unused terminals connected to VSS 3 V<sub>I</sub> - Input Voltage - V 92CS-30919 Figure 8





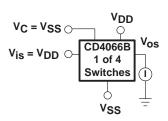
Measured on Boonton capacitance bridge, model 75a (1 MHz); test-fixture capacitance nulled out.

Figure 10. Typical On Characteristics for One of Four Channels



All unused terminals are connected to VSS.

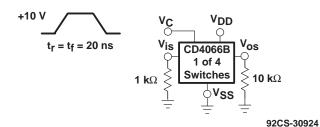
Figure 12. Propagation Delay Time Signal Input  $(V_{is})$  to Signal Output  $(V_{os})$ 



92CS-30922

All unused terminals are connected to VSS.

Figure 11. Off-Switch Input or Output Leakage

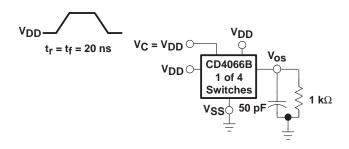


3200-0

All unused terminals are connected to VSS.

Figure 13. Crosstalk-Control Input to Signal Output



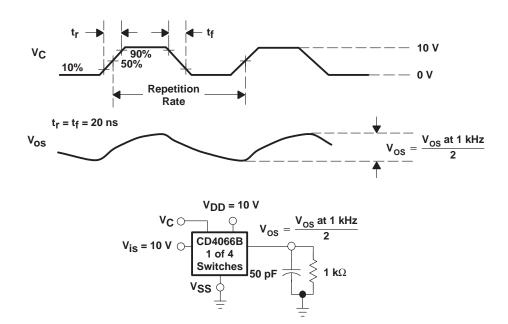


NOTES: A. All unused terminals are connected to  $V_{\mbox{SS}}$ .

92CS-30925

B. Delay is measured at  $V_{OS}$  level of +10% from ground (turn-on) or on-state output level (turn-off).

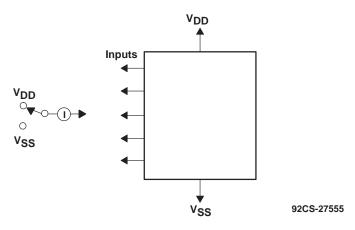
Figure 14. Propagation Delay, t<sub>PLH</sub>, t<sub>PHL</sub> Control-Signal Output



All unused terminals are connected to  $V_{SS}$ .

92CS-30925

Figure 15. Maximum Allowable Control-Input Repetition Rate



Measure inputs sequentially to both VDD and VSS. Connect all unused inputs to either VDD or VSS. Measure control inputs only.

Figure 16. Input Leakage-Current Test Circuit

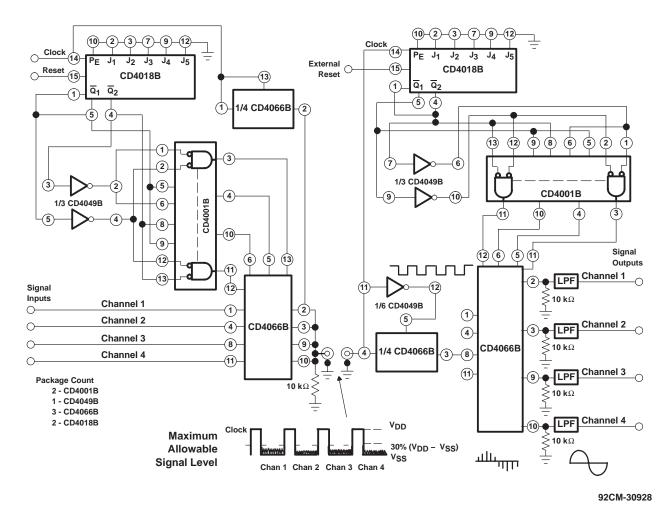
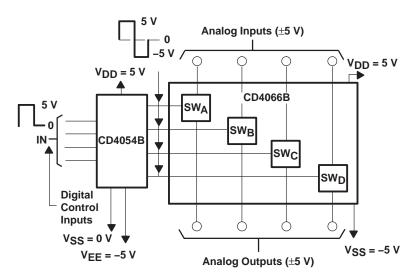


Figure 17. Four-Channel PAM Multiplex System Diagram





92CS-30927

Figure 18. Bidirectional Signal Transmission Via Digital Control Logic

SCHS051D - NOVEMBER 1998 - REVISED SEPTEMBER 2003

#### **APPLICATION INFORMATION**

In applications that employ separate power sources to drive  $V_{DD}$  and the signal inputs, the  $V_{DD}$  current capability should exceed  $V_{DD}/R_L$  ( $R_L$  = effective external load of the four CD4066B bilateral switches). This provision avoids any permanent current flow or clamp action on the  $V_{DD}$  supply when power is applied or removed from the CD4066B.

In certain applications, the external load-resistor current can include both  $V_{DD}$  and signal-line components. To avoid drawing  $V_{DD}$  current when switch current flows into terminals 1, 4, 8, or 11, the voltage drop across the bidirectional switch must not exceed 0.8 V (calculated from  $r_{on}$  values shown).

No V<sub>DD</sub> current will flow through R<sub>L</sub> if the switch current flows into terminals 2, 3, 9, or 10.







18-Oct-2013

#### **PACKAGING INFORMATION**

| Orderable Device | Status   | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan                   | Lead/Ball Finish  | MSL Peak Temp                | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|----------|--------------|--------------------|------|----------------|----------------------------|-------------------|------------------------------|--------------|----------------------|---------|
| CD4066BE         | ACTIVE   | PDIP         | N                  | 14   | 25             | Pb-Free<br>(RoHS)          | CU NIPDAU         | N / A for Pkg Type           | -55 to 125   | CD4066BE             | Samples |
| CD4066BEE4       | ACTIVE   | PDIP         | N                  | 14   | 25             | Pb-Free<br>(RoHS)          | CU NIPDAU         | N / A for Pkg Type           | -55 to 125   | CD4066BE             | Samples |
| CD4066BF         | ACTIVE   | CDIP         | J                  | 14   | 1              | TBD                        | A42               | N / A for Pkg Type           | -55 to 125   | CD4066BF             | Samples |
| CD4066BF3A       | ACTIVE   | CDIP         | J                  | 14   | 1              | TBD                        | A42               | N / A for Pkg Type           | -55 to 125   | CD4066BF3A           | Samples |
| CD4066BF3AS2283  | OBSOLETE | CDIP         | J                  | 14   |                | TBD                        | Call TI           | Call TI                      |              |                      |         |
| CD4066BF3AS2534  | OBSOLETE | CDIP         | J                  | 14   |                | TBD                        | Call TI           | Call TI                      |              |                      |         |
| CD4066BM         | ACTIVE   | SOIC         | D                  | 14   | 50             | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM -55 to 12 |              | CD4066BM             | Samples |
| CD4066BM96       | ACTIVE   | SOIC         | D                  | 14   | 2500           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU   CU SN | Level-1-260C-UNLIM           | -55 to 125   | CD4066BM             | Samples |
| CD4066BM96E4     | ACTIVE   | SOIC         | D                  | 14   | 2500           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066BM             | Samples |
| CD4066BM96G4     | ACTIVE   | SOIC         | D                  | 14   | 2500           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066BM             | Samples |
| CD4066BME4       | ACTIVE   | SOIC         | D                  | 14   | 50             | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066BM             | Samples |
| CD4066BMG4       | ACTIVE   | SOIC         | D                  | 14   | 50             | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066BM             | Samples |
| CD4066BMT        | ACTIVE   | SOIC         | D                  | 14   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066BM             | Samples |
| CD4066BMTE4      | ACTIVE   | SOIC         | D                  | 14   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066BM             | Samples |
| CD4066BMTG4      | ACTIVE   | SOIC         | D                  | 14   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066BM             | Samples |
| CD4066BNSR       | ACTIVE   | SO           | NS                 | 14   | 2000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | CU NIPDAU Level-1-260C-UNLIM |              | CD4066B              | Samples |
| CD4066BNSRE4     | ACTIVE   | SO           | NS                 | 14   | 2000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066B              | Samples |
| CD4066BNSRG4     | ACTIVE   | SO           | NS                 | 14   | 2000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU         | Level-1-260C-UNLIM           | -55 to 125   | CD4066B              | Samples |



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#### PACKAGE OPTION ADDENDUM

18-Oct-2013

| Orderable Device | Status | Package Type | Package | Pins | Package | Eco Plan                   | Lead/Ball Finish | MSL Peak Temp      | Op Temp (°C) | Device Marking       | Samples |
|------------------|--------|--------------|---------|------|---------|----------------------------|------------------|--------------------|--------------|----------------------|---------|
|                  | (1)    |              | Drawing |      | Qty     | (2)                        | (6)              | (3)                |              | (4/5)                |         |
| CD4066BPW        | ACTIVE | TSSOP        | PW      | 14   | 90      | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-1-260C-UNLIM | -55 to 125   | CM066B               | Samples |
| CD4066BPWE4      | ACTIVE | TSSOP        | PW      | 14   | 90      | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-1-260C-UNLIM | -55 to 125   | CM066B               | Samples |
| CD4066BPWG4      | ACTIVE | TSSOP        | PW      | 14   | 90      | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-1-260C-UNLIM | -55 to 125   | CM066B               | Samples |
| CD4066BPWR       | ACTIVE | TSSOP        | PW      | 14   | 2000    | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-1-260C-UNLIM | -55 to 125   | CM066B               | Samples |
| CD4066BPWRE4     | ACTIVE | TSSOP        | PW      | 14   | 2000    | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-1-260C-UNLIM | -55 to 125   | CM066B               | Samples |
| CD4066BPWRG4     | ACTIVE | TSSOP        | PW      | 14   | 2000    | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-1-260C-UNLIM | -55 to 125   | CM066B               | Samples |
| JM38510/05852BCA | ACTIVE | CDIP         | J       | 14   | 1       | TBD                        | A42              | N / A for Pkg Type | -55 to 125   | JM38510/<br>05852BCA | Samples |
| M38510/05852BCA  | ACTIVE | CDIP         | J       | 14   | 1       | TBD                        | A42              | N / A for Pkg Type | -55 to 125   | JM38510/<br>05852BCA | Samples |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



#### PACKAGE OPTION ADDENDUM

18-Oct-2013

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF CD4066B, CD4066B-MIL:

Catalog: CD4066B

Automotive: CD4066B-Q1, CD4066B-Q1

Military: CD4066B-MIL

#### NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military QML certified for Military and Defense Applications

## PACKAGE MATERIALS INFORMATION

www.ti.com 11-Oct-2013

#### TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width     |
|----|---|
|    | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

Q3 i Q4

#### Sprocket Holes 00000000 Q1 I Q2 Q1 I Q2 User Direction of Feed Q3 i Q4

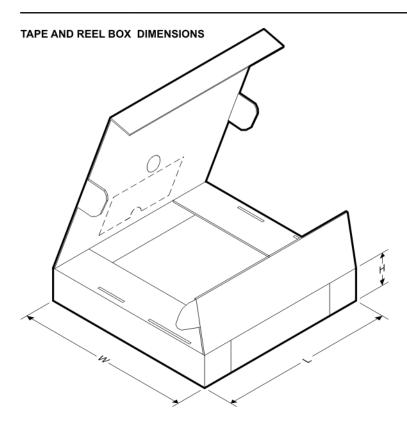
Pocket Quadrants

#### \*All dimensions are nominal

| Device       | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|--------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| CD4066BM96   | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.0        | 2.1        | 8.0        | 16.0      | Q1               |
| CD4066BM96   | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.0        | 2.1        | 8.0        | 16.0      | Q1               |
| CD4066BM96   | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.8                     | 6.5        | 9.5        | 2.3        | 8.0        | 16.0      | Q1               |
| CD4066BM96G4 | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.0        | 2.1        | 8.0        | 16.0      | Q1               |
| CD4066BM96G4 | SOIC            | D                  | 14 | 2500 | 330.0                    | 16.4                     | 6.5        | 9.0        | 2.1        | 8.0        | 16.0      | Q1               |
| CD4066BMT    | SOIC            | D                  | 14 | 250  | 330.0                    | 16.4                     | 6.5        | 9.0        | 2.1        | 8.0        | 16.0      | Q1               |
| CD4066BNSR   | SO              | NS                 | 14 | 2000 | 330.0                    | 16.4                     | 8.2        | 10.5       | 2.5        | 12.0       | 16.0      | Q1               |
| CD4066BPWR   | TSSOP           | PW                 | 14 | 2000 | 330.0                    | 12.4                     | 6.9        | 5.6        | 1.6        | 8.0        | 12.0      | Q1               |

**PACKAGE MATERIALS INFORMATION** 

www.ti.com 11-Oct-2013



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| CD4066BM96   | SOIC         | D               | 14   | 2500 | 367.0       | 367.0      | 38.0        |
| CD4066BM96   | SOIC         | D               | 14   | 2500 | 333.2       | 345.9      | 28.6        |
| CD4066BM96   | SOIC         | D               | 14   | 2500 | 364.0       | 364.0      | 27.0        |
| CD4066BM96G4 | SOIC         | D               | 14   | 2500 | 333.2       | 345.9      | 28.6        |
| CD4066BM96G4 | SOIC         | D               | 14   | 2500 | 367.0       | 367.0      | 38.0        |
| CD4066BMT    | SOIC         | D               | 14   | 250  | 367.0       | 367.0      | 38.0        |
| CD4066BNSR   | SO           | NS              | 14   | 2000 | 367.0       | 367.0      | 38.0        |
| CD4066BPWR   | TSSOP        | PW              | 14   | 2000 | 367.0       | 367.0      | 35.0        |

## 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



# D (R-PDSO-G14)

#### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



# D (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
  - Sody length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



#### **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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